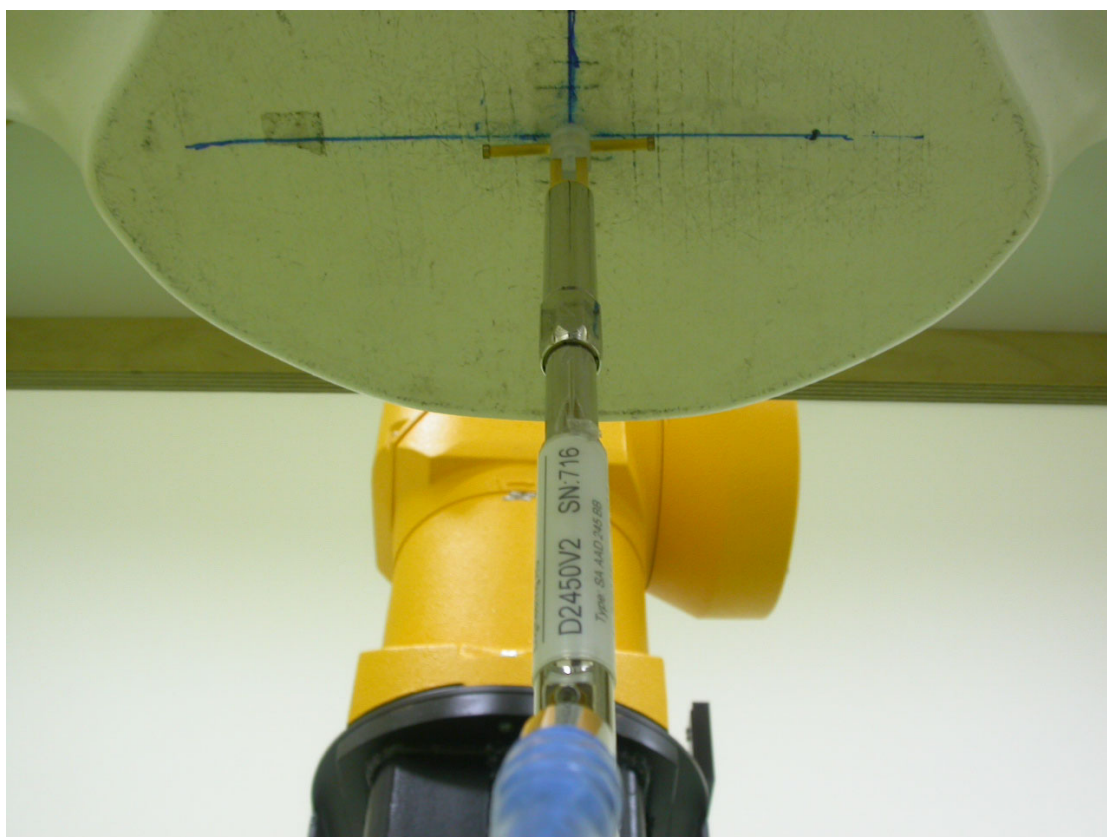
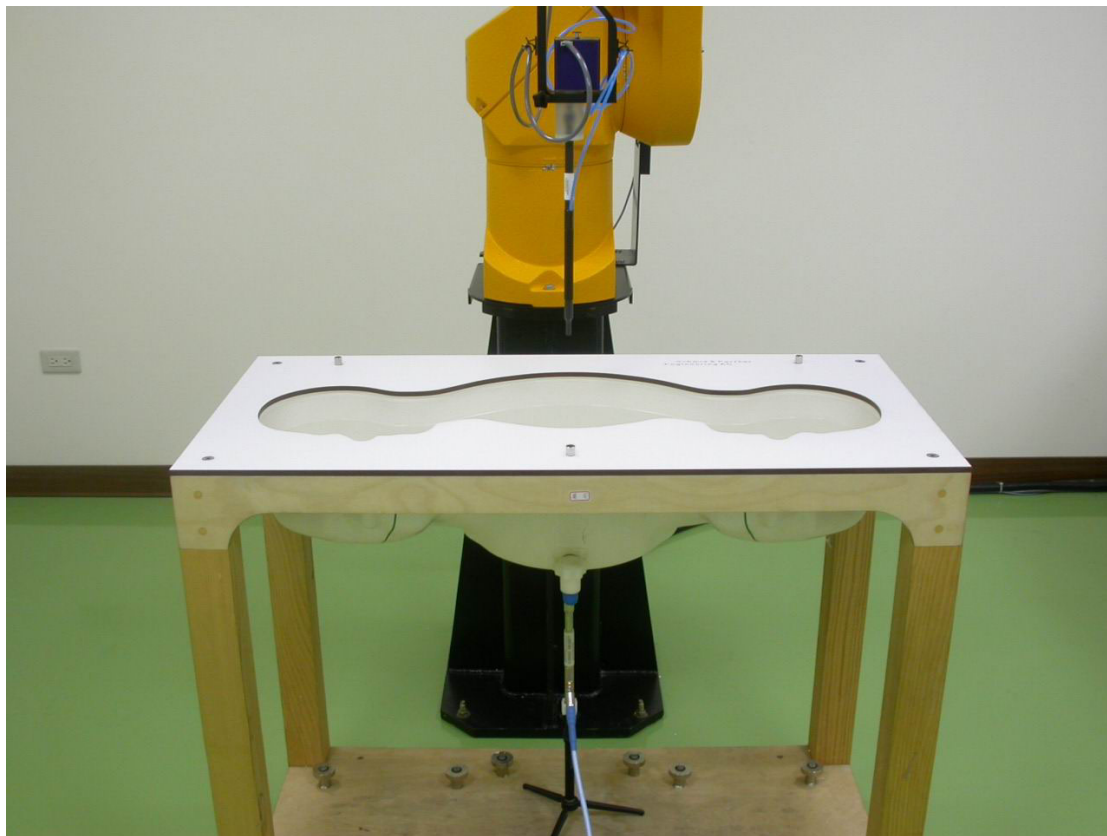


APPENDIX B : ADT SAR MEASUREMENT SYSTEM



APPENDIX C: PHOTOGRAPHS OF SYSTEM VALIDATION





APPENDIX D: SYSTEM CERTIFICATE & CALIBRATION

D1: SAM PHANTOM

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

Certificate of conformity / First Article Inspection

Item	SAM Twin Phantom V4.0
Type No	QD 000 P40 CA
Series No	TP-1150 and higher
Manufacturer / Origin	Untersee Composites Hauptstr. 69 CH-8559 Fruthwilen Switzerland

Tests

The series production process used allows the limitation to test of first articles. Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series units (called samples).

Test	Requirement	Details	Units tested
Shape	Compliance with the geometry according to the CAD model.	IT'IS CAD File (*)	First article, Samples
Material thickness	Compliant with the requirements according to the standards	2mm +/- 0.2mm in specific areas	First article, Samples
Material parameters	Dielectric parameters for required frequencies	200 MHz – 3 GHz Relative permittivity < 5 Loss tangent < 0.05.	Material sample TP 104-5
Material resistivity	The material has been tested to be compatible with the liquids defined in the standards	Liquid type HSL 1800 and others according to the standard.	Pre-series, First article

Standards

- [1] CENELEC EN 50361
- [2] IEEE P1528-200x draft 6.5
- [3] IEC PT 62209 draft 0.9

(*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of [1] and [3].

Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standard [1] and draft standards [2] and [3].

Date 28.02.2002

Signature / Stamp

F. Bombault

**Schmid & Partner
Engineering AG**

Zeughausstrasse 43, CH-8004 Zurich
Tel. +41 1 245 97 00, Fax +41 1 245 97 79

Johannes Kofler



D2: DOSIMETRIC E-FIELD PROBE

IMPORTANT NOTICE

USAGE OF PROBES IN ORGANIC SOLVENTS

Diethylene Glycol Monobutyl Ether (the basis for liquids above 1 GHz), as many other organic solvents, is a very effective softener for synthetic materials. These solvents can cause irreparable damage to certain SPEAG products, except those which are explicitly declared as compliant with organic solvents.

Compatible Probes:

- ET3DV6
- ET3DV6R
- ES3DV2
- ER3DV6
- H3DV6

Important Note for ET3DV6 Probes:

The ET3DV6 probes shall not be exposed to solvents longer than necessary for the measurements and shall be cleaned daily after use with warm water and stored dry.

Client **ADT (Auden)**

CALIBRATION CERTIFICATE

Object(s) **ET3DV6 - SN:1687**

Calibration procedure(s) **QA CAL-01.v2
Calibration procedure for dosimetric E-field probes**

Calibration date: **August 26, 2004**


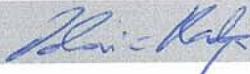
Condition of the calibrated item **In Tolerance (according to the specific calibration document)**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E4419B	GB41293874	5-May-04 (METAS, No 251-00388)	May-05
Power sensor E4412A	MY41495277	5-May-04 (METAS, No 251-00388)	May-05
Reference 20 dB Attenuator	SN: 5086 (20b)	3-May-04 (METAS, No 251-00389)	May-05
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03 (Sintrel SCS No. E030020)	Sep-04
Power sensor HP 8481A	MY41092180	18-Sep-02 (SPEAG, in house check Oct03)	In house check: Oct 05
RF generator HP 8684C	US3642U01700	4-Aug-99 (SPEAG, in house check Aug02)	In house check: Aug05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct03)	In house check: Oct 05

	Name	Function	Signature
Calibrated by:	Nico Vetterli	Technician	
Approved by:	Katja Pokovic	Laboratory Director	

Date issued: August 26, 2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

Probe ET3DV6

SN:1687

Manufactured:	May 28, 2002
Last calibrated:	November 24, 2003
Recalibrated:	August 26, 2004

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: ET3DV6 SN:1687

Sensitivity in Free Space

NormX	1.87 $\mu\text{V}/(\text{V}/\text{m})^2$
NormY	1.84 $\mu\text{V}/(\text{V}/\text{m})^2$
NormZ	1.64 $\mu\text{V}/(\text{V}/\text{m})^2$

Diode Compression^A

DCP X	95	mV
DCP Y	95	mV
DCP Z	95	mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 7.

Boundary Effect

Head 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	10.4	6.1
SAR _{be} [%]	With Correction Algorithm	0.3	0.5

Head 1800 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	13.0	8.9
SAR _{be} [%]	With Correction Algorithm	0.2	0.1

Sensor Offset

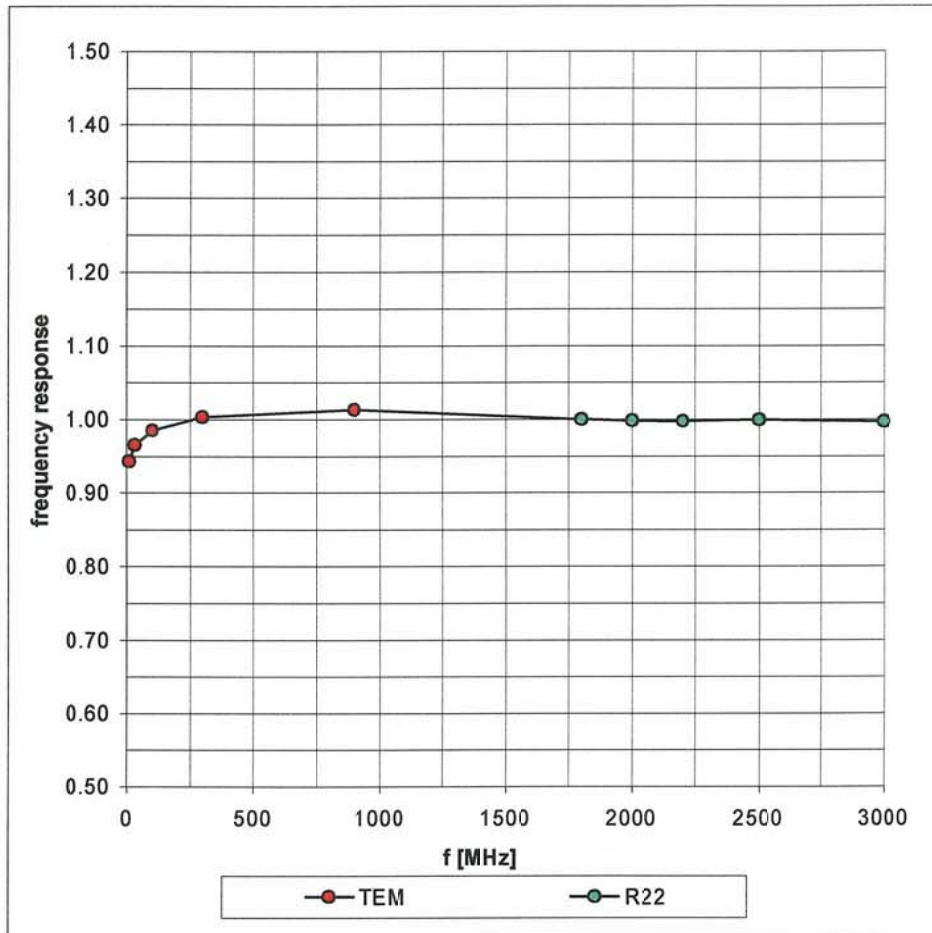
Probe Tip to Sensor Center	2.7 mm
Optical Surface Detection	in tolerance

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

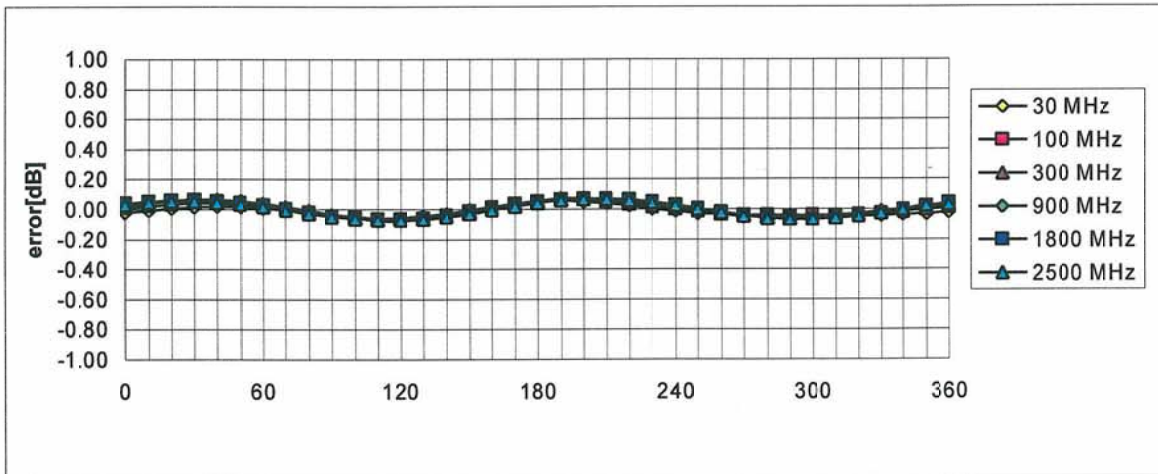
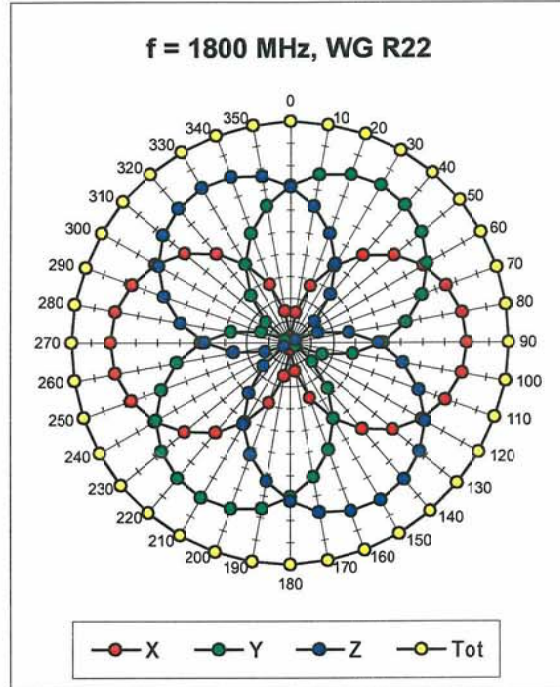
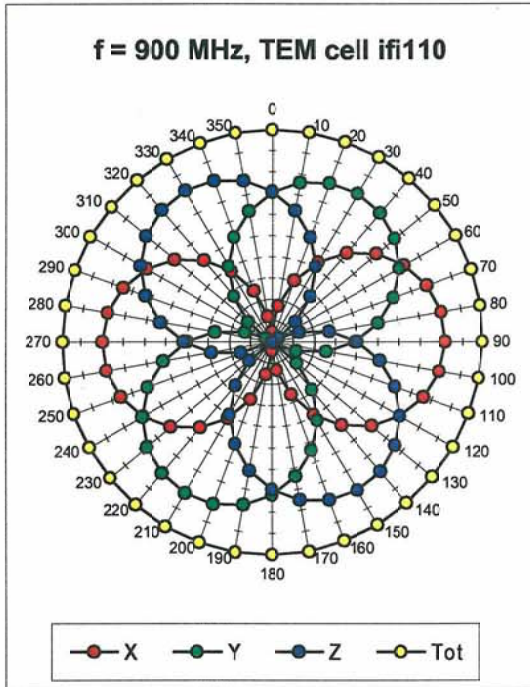
^A numerical linearization parameter: uncertainty not required

Frequency Response of E-Field

(TEM-Cell:ifi110, Waveguide R22)

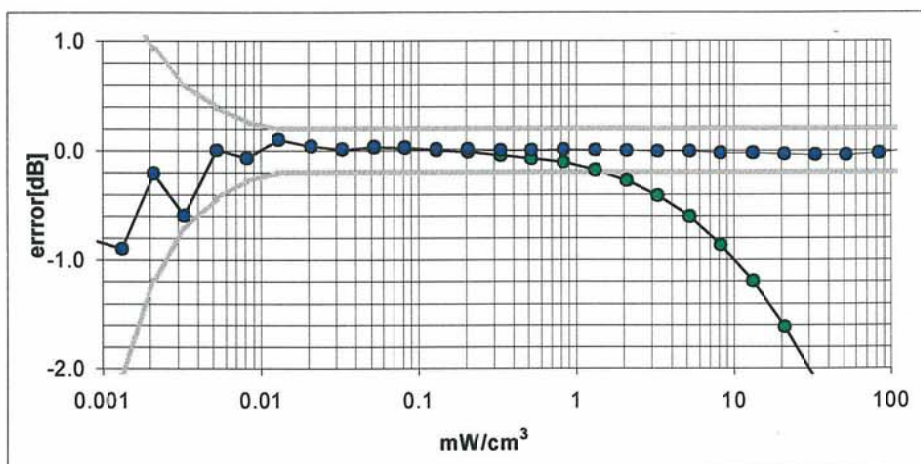
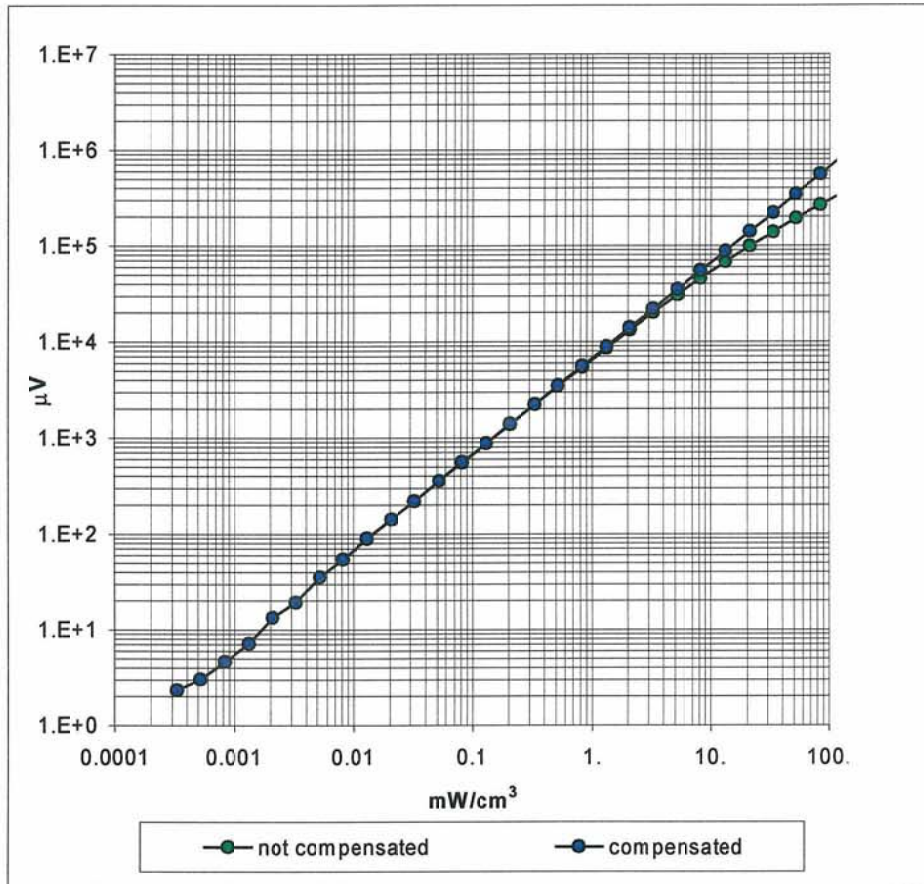


Receiving Pattern (ϕ), $\theta = 0^\circ$



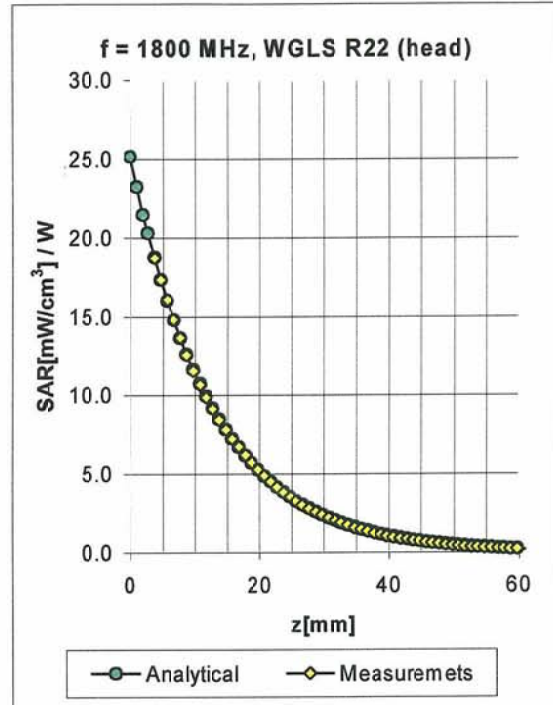
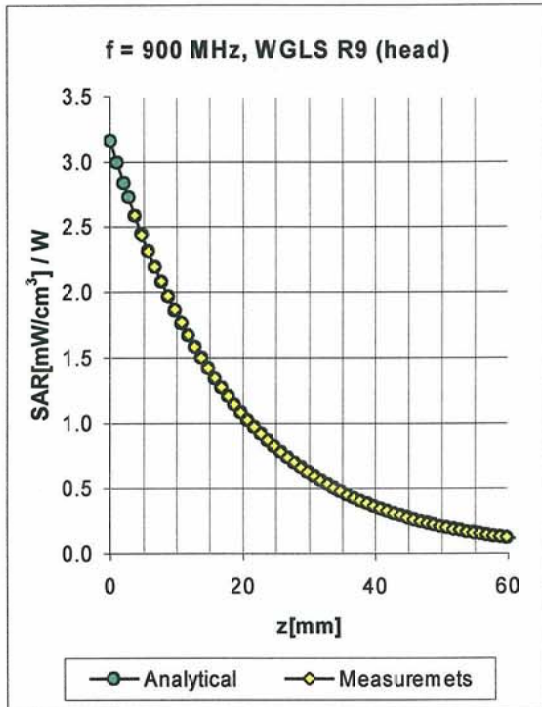
Axial Isotropy Error $\lt; \pm 0.2 \text{ dB}$

Dynamic Range f(SAR_{head}) (Waveguide R22)



Probe Linearity Error $< \pm 0.2$ dB

Conversion Factor Assessment

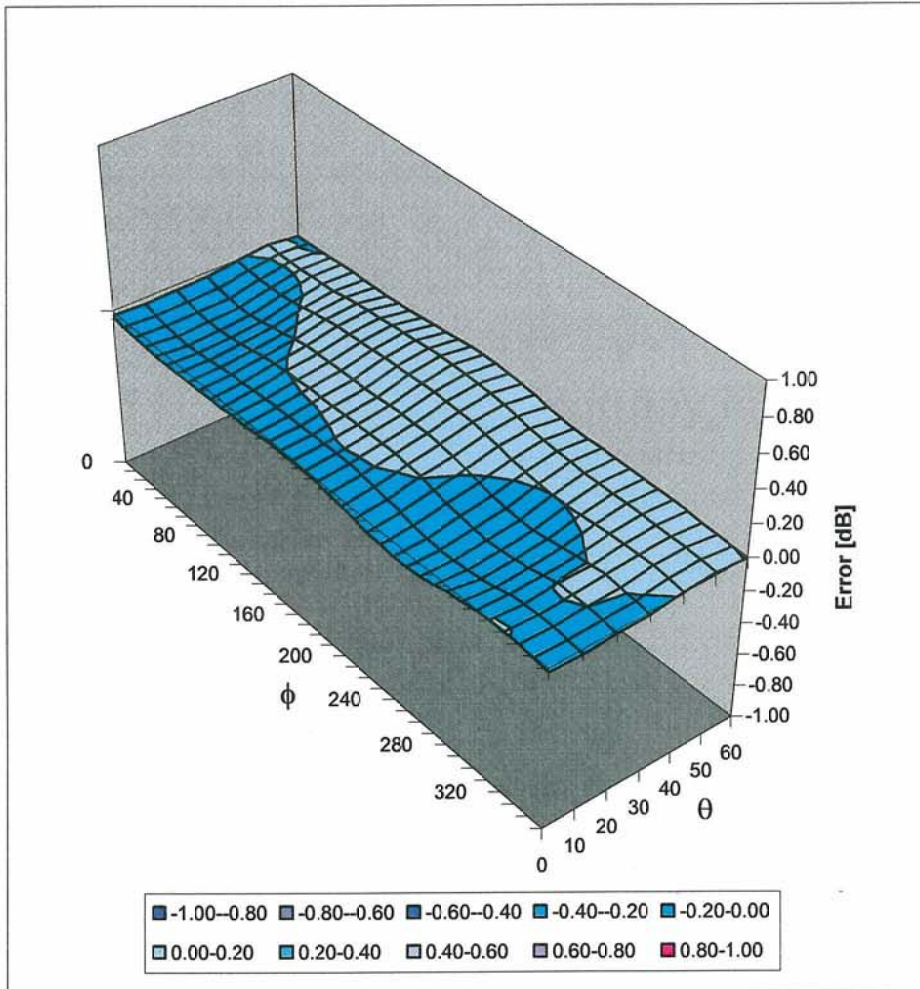


f [MHz]	Validity [MHz] ^B	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF	Uncertainty
900	800-1000	Head	41.5 ± 5%	0.97 ± 5%	0.38	2.58	6.34	± 11.3% (k=2)
1800	1710-1910	Head	40.0 ± 5%	1.40 ± 5%	0.46	2.71	5.16	± 11.7% (k=2)
2450	2400-2500	Head	39.2 ± 5%	1.80 ± 5%	0.90	1.93	4.41	± 9.7% (k=2)
900	800-1000	Body	55.0 ± 5%	1.05 ± 5%	0.52	2.10	6.06	± 11.3% (k=2)
1800	1710-1910	Body	53.3 ± 5%	1.52 ± 5%	0.52	2.88	4.54	± 11.7% (k=2)
2450	2400-2500	Body	52.7 ± 5%	1.95 ± 5%	1.04	1.62	4.23	± 9.7% (k=2)

^B The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (θ, ϕ), $f = 900$ MHz



Spherical Isotropy Error <math>\lt; \pm 0.4 dB



D3: DAE

IMPORTANT NOTICE

USAGE OF THE DAE 3

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE3 unit is connected to a fragile 3-pin battery connector. Customer is responsible to apply utmost caution not to bend or damage the connector when changing batteries.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Client **Auden ADT**

CALIBRATION CERTIFICATE

Object(s) **DAE3 - SD 000 D03 AA - SN: 510**

Calibration procedure(s) **QA CAL-06.v7
Calibration procedure for the data acquisition unit (DAE)**

Calibration date: **17.08.2004**



Condition of the calibrated item **In Tolerance (according to the specific calibration document)**

This calibration statement documents traceability of M&TE used in the calibration procedures and conformity of the procedures with the ISO/IEC 17025 international standard.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03	Sep-04

	Name	Function	Signature
Calibrated by:	Philipp Storchenegger	Technician	
Approved by:	Fin Bomholt	R&D Director	

Date issued: 17.08.2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

1. DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.405	403.470	403.844
Low Range	3.95588	3.93301	3.95923
Connector Angle to be used	in DASY System		43 °

High Range	Input (μ V)	Reading (μ V)	Error (%)
Channel X + Input	200000	199999.5	0.00
Channel X + Input	20000	20004.1	0.02
Channel X - Input	20000	-19988.8	-0.06
Channel Y + Input	200000	199999.9	0.00
Channel Y + Input	20000	19999.3	0.00
Channel Y - Input	20000	-19993.8	-0.03
Channel Z + Input	200000	199999.6	0.00
Channel Z + Input	20000	20005.6	0.03
Channel Z - Input	20000	-19995.4	-0.02

Low Range	Input (μ V)	Reading (μ V)	Error (%)
Channel X + Input	2000	1999.96	0.00
Channel X + Input	200	200.00	0.00
Channel X - Input	200	-200.34	0.17
Channel Y + Input	2000	2000.03	0.00
Channel Y + Input	200	199.39	-0.31
Channel Y - Input	200	-200.81	0.41
Channel Z + Input	2000	2000.07	0.00
Channel Z + Input	200	199.29	-0.36
Channel Z - Input	200	-201.07	0.53

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Reading (μ V)	Low Range Reading (μ V)
Channel X	200	17.42	16.88
	- 200	-17.00	-17.10
Channel Y	200	14.86	14.26
	- 200	-15.53	-16.14
Channel Z	200	-8.63	-8.44
	- 200	7.15	7.51

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.45	1.22
Channel Y	200	0.25	-	4.38
Channel Z	200	-1.29	0.37	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15983	16854
Channel Y	16210	16793
Channel Z	16173	16131

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.46	-0.28	1.02	0.27
Channel Y	-1.06	-1.87	-0.38	0.25
Channel Z	-0.15	-1.01	0.88	0.36

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2001	201.3
Channel Y	0.2001	199.6
Channel Z	0.2001	200.7

8. Low Battery Alarm Voltage

typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption

typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9